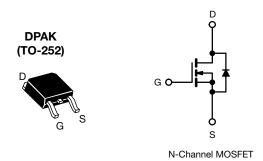


Vishay Siliconix

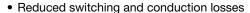
## **E Series Power MOSFET**



PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650				
R <sub>DS(on)</sub> typ. (Ω) at 25 °C	V <sub>GS</sub> = 10 V	0.320			
Q <sub>g</sub> max. (nC)	52				
Q <sub>gs</sub> (nC)	6				
Q <sub>gd</sub> (nC)	13				
Configuration	Single				

#### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)



- Ultra low gate charge (Qa)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see <a href="https://www.vishay.com/doc?99912"><u>www.vishay.com/doc?99912</u></a>



#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

ORDERING INFORMATION	
Package	DPAK (TO-252)
Lead (Pb)-free and halogen-free	SiHD9N60E-GE3

ABSOLUTE MAXIMUM RATINGS	(T <sub>C</sub> = 25 °C,	, unle	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-source voltage			$V_{DS}$	600			
Gate-source voltage				V <sub>GS</sub>	± 30	V	
Continuous drain current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 1	10.1/	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	- I <sub>D</sub>	9	A	
	V <sub>GS</sub> at 1	10 V	T <sub>C</sub> = 100 °C		6		
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	22			
Linear derating factor				0.63	W/°C		
Single pulse avalanche energy b			E <sub>AS</sub>	111	mJ		
Maximum power dissipation			P <sub>D</sub>	78	W		
Operating junction and storage temperature range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		
Drain-source voltage slope	Т	T <sub>J</sub> = 125 °C		ط/\/ط+	70	1//20	
Reverse diode dV/dt <sup>d</sup>			dV/dt	40	- V/ns		
Soldering recommendations (peak temperature	e) c	For 10 s			300	°C	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b.  $V_{DD} = 140 \text{ V}$ , starting  $T_J = 25 \,^{\circ}\text{C}$ ,  $L = 28.2 \,\text{mH}$ ,  $R_q = 25 \,\Omega$ ,  $I_{AS} = 2.8 \,\text{A}$ .
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , dI/dt = 100 A/ $\mu$ s, starting  $T_J = 25$  °C.



# Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	$R_{thJA}$	-	62	°C/W		
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	1.6	C/ VV		

PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT
Static		•					
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> :	600	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I <sub>D</sub> = 1 mA			-	V/°C
Gate-source threshold voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			4.5	V
Oata assura laslana	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-source leakage			V <sub>GS</sub> = ± 30 V		-	± 1	μΑ
<b>-</b>		V <sub>DS</sub> =	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V		-	1	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 480 \	V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	10	μA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.5 A	-	0.320	0.368	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 30 V, I <sub>D</sub> = 4.5 A		-	2.4	-	S
Dynamic		•					
Input capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$ f = 1  MHz		-	778	-	pF
Output capacitance	C <sub>oss</sub>			-	48	-	
Reverse transfer capacitance	C <sub>rss</sub>			-	4	-	
Effective output capacitance, energy related <sup>a</sup>	$C_{o(er)}$	V 0V/to 400 V V 0 V		-	29	-	
Effective output capacitance, time related <sup>b</sup>	C <sub>o(tr)</sub>	V <sub>DS</sub> = 0 \	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$		138	-	
Total gate charge	Qg		V I <sub>D</sub> = 4.5 A, V <sub>DS</sub> = 480 V	-	26	52	
Gate-source charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	6	-	nC
Gate-drain charge	Q <sub>gd</sub>			-	13	-	1
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 4.5 A,		-	14	28	- ns
Rise time	t <sub>r</sub>			-	13	26	
Turn-off delay time	t <sub>d(off)</sub>	V <sub>GS</sub> :	$V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$		31	62	
Fall time	t <sub>f</sub>	1		-	12	24	
Gate input resistance	$R_g$	f = 1 MHz, open drain		0.4	1.2	2.4	Ω
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9	
Pulsed diode forward current	I <sub>SM</sub>			-	-	22	A
Diode forward voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 4.5 A, V <sub>GS</sub> = 0 V		-	-	1.2	V
Reverse recovery time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 4.5 \text{ A},$ $dI/dt = 100 \text{ A/}\mu\text{s}, V_R = 25 \text{ V}$		-	207	414	ns
Reverse recovery charge	Q <sub>rr</sub>			-	2.2	4.4	μC
Reverse recovery current	I <sub>RRM</sub>			_	20	-	A

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

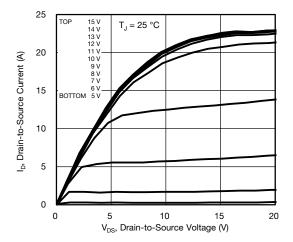


Fig. 1 - Typical Output Characteristics

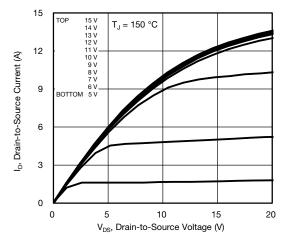


Fig. 2 - Typical Output Characteristics

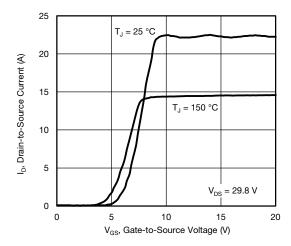


Fig. 3 - Typical Transfer Characteristics

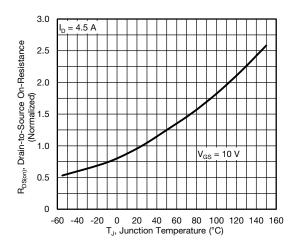


Fig. 4 - Normalized On-Resistance vs. Temperature

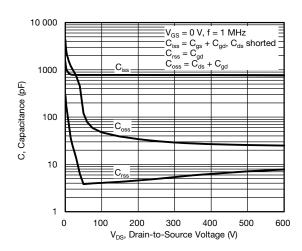


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

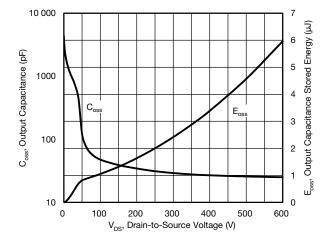


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 



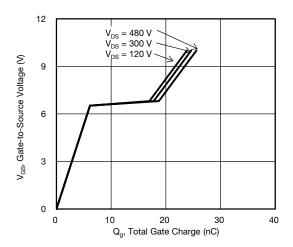


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

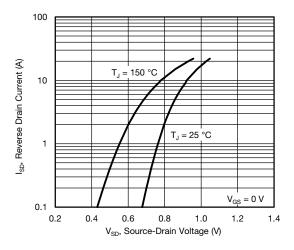


Fig. 8 - Typical Source-Drain Diode Forward Voltage

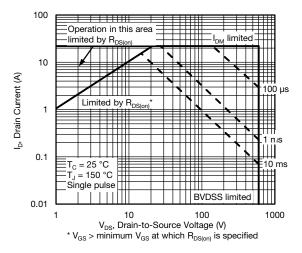


Fig. 9 - Maximum Safe Operating Area

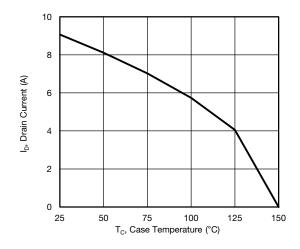


Fig. 10 - Maximum Drain Current vs. Case Temperature

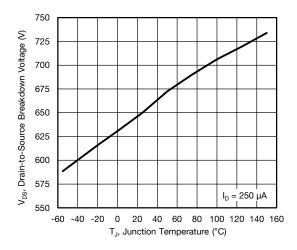


Fig. 11 - Temperature vs. Drain-to-Source Voltage



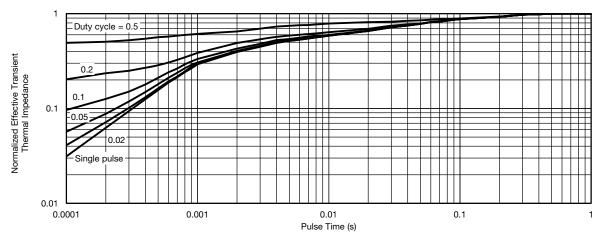


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

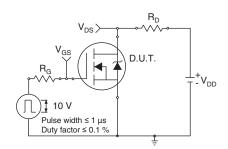


Fig. 13 - Switching Time Test Circuit

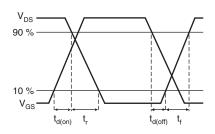


Fig. 14 - Switching Time Waveforms

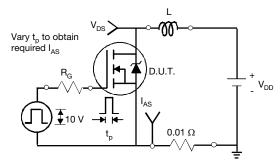


Fig. 15 - Unclamped Inductive Test Circuit

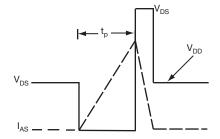


Fig. 16 - Unclamped Inductive Waveforms

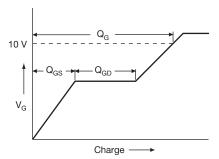


Fig. 17 - Basic Gate Charge Waveform

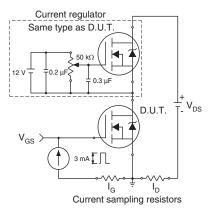
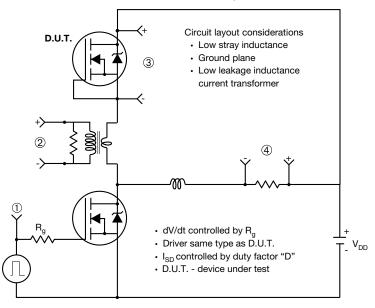


Fig. 18 - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



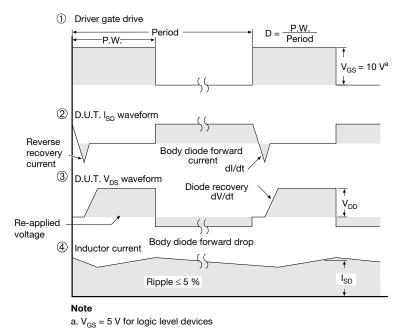


Fig. 19 - For N-Channel

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